

FILE EAST: 10752210 fuses with guard rings and etch stop.wsp:1

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L6: (2) 5,567,643 .pn;

L7: (5) "bae jun shik".in.

L14: (10707) (guard\$4 protect\$4) adj ring )

L15: (871807) fuse link

L18: (243) 14 with 15

L17: (115) 18.ab.

L18: (108192) 15.clm.

L19: (1397) 14.clm.

L20: (26) 17 and 18

L21: (27) 17 and 18

L22: (2) 21 not 20

L23: (2) 10,364842

(1) 09,948877

(1738) "KONINKLLIKE PHILIPS".as.

(0) 10,752210

(4) 6716679.pn.

(4) ("6121073" "6573125").pn.

(2) "09069571"

(206570) seiko.as.

(123) "FURUHATA, TOMOYUKI".in.

(113) seiko.as. and "FURUHATA, TOMOYUKI".in.

(523345) fus \$4

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DBs: USPAT:US POPUB:EPO:JPO:DERVENT:IBM:TDG

Default operator: OR

17 and 19

Plurals

Highlight all hit terms initially

July 2004

#	Inv	Doc	Page	Title	Current	Current	Current	Retrieval	S	C	P	Image	Doc	P
1	Bae, Myoung	US 2003016	20030:3	Methods of forming fuse box guard rings for	257/529:257/E23.15								US 200301	
2	Liaw, Jhon-J	US 6255715	20010:1	Fuse window guard ring structure for nitride	257/529:257/209;								US 625571	
3	Chen, Chung	US 5652459	19970:1	Moisture guard ring for integrated circuit ap	257/529:257/805;								US 565245	
4	Minn, Eun-Yo	US 2001005	20011:1	Fuse area structure having guard ring surrou	438/281:257/E21.66								US 200100	
5	Bae, Myoung	US 6716679	20040:2	Methods of forming fuse box guard rings for	438/132:257/529;								US 671667	
6	Minn, Eun-yo	US 6509255	20030:1	Fuse area structure having guard ring surrou	438/601:257/E21.66								US 650925	
7	Shiragaki, Ta	US 2004005	20040:3	Ring network for sharing protection resource	370/216:370/386								US 200400	
8	Maki, Yasuhi	US 2003021	20031:1	Semiconductor device	365/225:365/230.03								US 200302	
9	Kim, Byung-y	US 2003013	20030:2	Semiconductor device capable of preventing	438/132:257/E23.00								US 200301	
10	Shiragaki, Ta	US 6657952	20031:3	Ring network for sharing protection resource	370/223:370/244;								US 665795	

Ready

NUM